Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
09/940,148	SIU ET AL.
Examiner	Art Unit
Thien D. Tran	2665

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	400	12/10/2005	ΤΤ	
	396	12/10/2005	тт	
	367	12/10/2005	П	
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SEARCH NOT (INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT) 370/367, 370-375, 396, 397, 400, 410, 412,	12/10/2005	ТТ		
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